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To Examiner: Jack S.J. Chen Technology Center 2800	Total Pages Sent: 10 (including cover sheet)
Facsimile Number: (703) 872-9306	Transmission Date: January 24, 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Tews, *et al.* Docket No.: 00P9031US
Serial No: 09/714,356 Art Unit: 2813
Date Filed: November 16, 2000
Title: Nitrogen Implantation Using a Shadow Effect to Control Gate Oxide Thickness
in DRAM Semiconductor

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- Certification of Facsimile Transmission (1 page)
- Response to Restriction (9 pages)

Respectfully submitted,


Kristin Hayes
Legal Assistant

Confirmation Respectfully Requested

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CENTRAL FAX CENTERApplicants: Tews, *et al.*

Docket No.: 00P9031US

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Serial No.: 09/714,356

Art Unit: 2813

Filed: November 16, 2000

Examiner: Chen, Jack S.J.

For: Nitrogen Implantation Using a Shadow Effect to Control Gate Oxide Thickness in
DRAM SemiconductorMail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450**RESPONSE TO RESTRICTION**

Dear Sir:

Applicant has received and reviewed the Office Action mailed on January 11, 2005 and respectfully requests reconsideration based on the following remarks.

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